Linearize optical distance sensors with a voltage-to-frequency converter

Jordan Dimitrov, Toronto, ON, Canada

A popular series of inexpensive distance sensors integrates an infrared emitting diode, a linear charge-coupled-device array, and a signal-processing circuit in one unit. The output is a dc voltage, V_s , that depends on the distance, D, in a non-linear manner (**Figure 1**).

To improve linearity, the manufacturer suggests using the relationship between the output voltage and the inverse value of the distance (**Figure 2**). You can use the curve-fitting utility of Excel software to calculate two or three coefficients of this alternative relationship, and a microcontroller can then use the coefficients to calculate distance from V_s . The calculation requires floating-point arithmetic, which results in a large amount of machine-language code, a difficulty for many microcontrollers due to their limited memory size.

This Design Idea describes a way to present the sensor response with better linearity and a circuit that eliminates the need for complex calculations to find the distance. The built-and-tested unit uses the Sharp GP2D120 sensor (Reference 1), which measures distances of 4 to 30 cm (40 to 300 mm). This sensor is currently out of production but may be available through some sources. If not, a similar but untested replacement is the Sharp GP2Y0A21YKOF (Reference 2), which measures distances of 10 to 80 cm (100 to 800 mm).

Figure 3 shows the linearity improvement you gain by using the inverse value of the voltage, V_s , versus distance. Figure 4 shows the circuit that provides a linear relationship between distance and another variable. The key component is a voltage-to-frequency converter, such as the AD654, between the sensor and the microcontroller (references 3 and 4). The sensor's response is $1/V_s$ =aD+b, where a and b are coefficients. The VFC has a linear



designideas



Figure 4 An AD654 VFC between the sensor and the microcontroller ensures a linear relation between pulse period and distance. A measurement calculates the 50Ω output impedance of the distance sensor. The LCD can be any generic device.

LISTING 1 DISTANCE-CALCULATION CODE

Measure	LDAA STAA	#\$01 TFLG1,X	;	Clear IC3 flag
	BRCLR	TFLG1,X \$01 *	;	Wait for a rising edge
	LDD	TIC3,X		
	STD	t1	;	Save time of pulse edge
	LDAA	#\$01	;	Clear IC3 flag
	STAA	TFLG1,X		
	BRCLR	TFLG1,X \$01 *	;	Wait for the next rising edge
	LDD	TIC3,X		
	STD	t2	;	Save time of 2nd pulse edge
	SUBD	t1	;	Calculate period
	SUBD	#10	;	Remove offset of the cal line
	STD	N	;	Save result
	RTS			

response, $f=S_FV_S$, where S_F is a coefficient. The pulse period is T=1/f. The microcontroller defines the period as a number of internal clock pulses, $N=T/T_{CLK}$. The period of clock pulses is 0.5 µsec, and it defines the values of the frequency-determining components of the VFC. From these **equations**, you can build a relationship between N and D: $N=(aD+b)/(S_F \times T_{CLK})$, which is a straight line. The hardware circuit's design performs the calculations; they do not take place when the microcontroller calculates distance.

The RC network at the sensor output matches the sensor-voltage swing to the VFC's input range and attenuates the 1-kHz noise riding on the sensor signal. The resistor divider modifies the system response to the form N=(aD+b)/ $(k_D \times S_F \times T_{CLK}) = \alpha \times D + \beta$, where k_D is the transfer ratio of the divider,

 α is the slope, and β is the offset.

Listing 1 shows the subroutine code for measuring and calculating the distance. Calibration is somewhat tedious because the sensor cannot measure zero distance. You adjust the slope of the last equation by using two reference distances and tweaking the 500 Ω trimming potentiometer at the VFC. If the reference distances are 80 and 220 mm, you must adjust for a difference of 140 between the corresponding numbers on the display. When you finish that task, use any of the reference numbers to calculate the offset. In the code, subtract the offset from the measured value of N. A test of the assembled circuit covers the whole measurement range in steps of 20 mm. The nonlinearity error is ± 3 mm, 2.7 times smaller than the error of the V_{o} -versus-1/D response.

Editor's note: The author teaches

a course on microcontrollers at a large community college in Toronto, ON, Canada. The course inspired this Design Idea. The Sharp distance sensor is an opportunity to show students that they can perform linearization using software or hardware, and they can compare the two approaches.EDN

REFERENCES

"GP2D120 Optoelectronic Device," Sharp Microelectronics, 2006, http:// bit.ly/Ap41QU.

GP2Y0A21YK0F Distance Measuring Sensor Unit," Sharp Microelectronics, Dec 1, 2006, http://bit.ly/y1o7g3.
"HC11 MC68HC11F1 Technical Data," Freescale Semiconductor Inc, http://bit.ly/A78Fq0.

 "AD654 Low Cost Monolithic Voltage-to-Frequency Converter," Analog Devices, http://bit.ly/AyRHT6.